December 2000



FDS3570

80V N-Channel PowerTrench[®] MOSFET

General Description

This N-Channel Logic Level MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

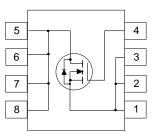
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(on)}}$ specifications resulting in DC/DC power supply designs with higher overall efficiency.

Features

• 9 A, 80 V. $R_{DS(ON)} = 0.020 \ \Omega \ @ V_{GS} = 10 \ V$ $R_{DS(ON)} = 0.023 \ \Omega \ @ V_{GS} = 6 \ V.$

- Fast switching speed.
- High performance trench technology for extremely low $\rm R_{\rm DS(ON)}.$
- High power and current handling capability.

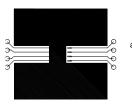




Absolute Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter		Ratings	Units	
V _{DSS}	Drain-Source Vo	ltage		80	V	
V _{GSS}	Gate-Source Vol	tage		±20	V	
ID	Drain Current -	Continuous	(Note 1a)	9	A	
	-	Pulsed		50		
P _D	Power Dissipatio	on for Single Operation	(Note 1a)	2.5	W	
			(Note 1b)	1.2		
			(Note 1c)	1		
TJ, T _{stg}	Operating and S	Storage Junction Temperature Range		-55 to +150	°C	
	•		•			
Therma R _{eJA}	I Characteri Thermal Resista	stics nce, Junction-to-Ambient	t (Note 1a)	50	°C/W	
R _{eJA}	Thermal Resista	nce, Junction-to-Ambient	. ,			
R _e JA R _e JC Packag	Thermal Resista Thermal Resista		(Note 1)	50 25 Tape Width	°C/W °C/W Quantity	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	ource Avalanche Ratings (Note 2)					
N _{DSS}	Single Pulse Drain-Source	$V_{DD} = 40 \text{ V}, I_D = 9 \text{ A}$			360	mJ
AR	Avalanche Energy Maximum Drain-Source Avalanche Cu	Irrent			9	Α
					-	
<u>Jff Char</u> 3V _{DSS}	acteristics Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	80	<u> </u>		V
	Breakdown Voltage Temperature	$V_{GS} = 0.0$, $I_D = 250 \mu\text{A}$ $I_D = 250 \mu\text{A}$, Referenced to	00	77		mV/°C
$\Delta T_{.1}$	Coefficient	$1_{\rm D} = 250$ PA, Referenced to $25^{\circ}{\rm C}$				
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, V_{GS} = 0 \text{ V}$			1	μд
GSSF	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage, Reverse	V_{GS} = -20 V, V_{DS} = 0 V			-100	nA
On Char	acteristics (Note 2)					
/ _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2	2.4	4	V
VGS(th)	Gate Threshold Voltage	$I_{\rm D} = 250 \ \mu \text{A}$, Referenced to		-7		mV/°C
ΔT_{J}	Temperature Coefficient	25°C				
20(011)	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}$		0.015	0.020	Ω
		$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 6 \text{ V}, I_D = 8.4 \text{ A}$		0.027	0.038	
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	25			Α
FS	Forward Transconductance	V _{DS} = 5 V, I _D = 7.6 A		40		S
Jynamic	Characteristics					
Dynamic C _{iss}	Input Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V,$		2750		pF
Coss	Output Capacitance	f = 1.0 MHz		280		pF
	Reverse Transfer Capacitance			140		pF
d(on)	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, \text{ I}_{D} = 1 \text{ A},$		20	32	ns
r	Turn-On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		12	24	ns
d(off)	Turn-Off Delay Time			60	95	ns
	Turn-Off Fall Time			24	38	ns
λ ^g	Total Gate Charge	$V_{DS} = 40 \text{ V}, \text{ I}_{D} = 9 \text{ A},$		54	76	nC
ג ג _{gs}	Gate-Source Charge	V _{GS} = 10 V		9.6		nC
2 _{gd}	Gate-Drain Charge			14		nC
		d Maximum Datinga				
s S	Durce Diode Characteristics ar Maximum Continuous Drain-Source D				2.1	А
s / _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 2.1 \text{ A}$ (Note 2)		0.72	1.2	V
es:				0.72	L 2	v



Scale 1 : 1 on letter size paper

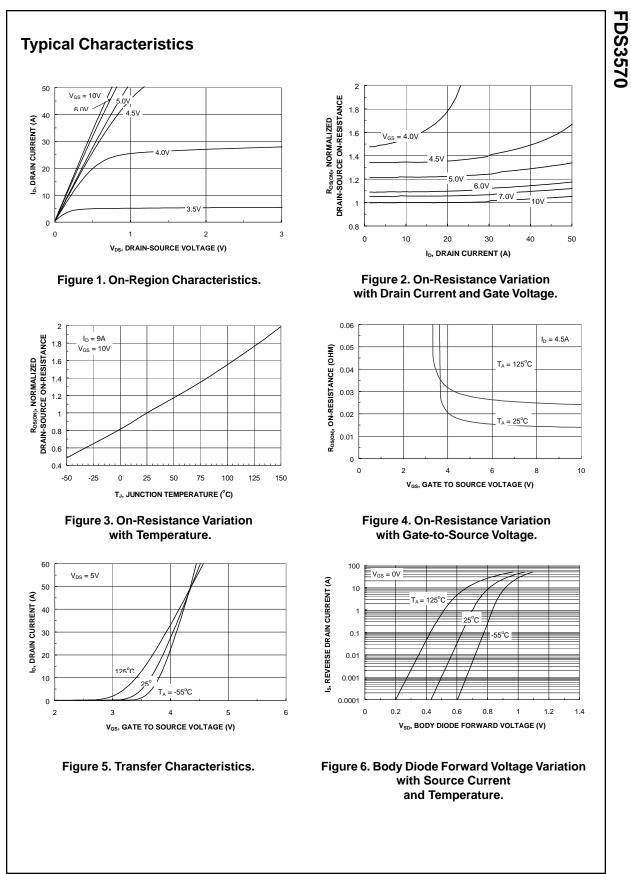
2. Pulse Test: Pulse Width $\leq 300~\mu\text{s},$ Duty Cycle $\leq 2.0\%$

b) 105° C/W when mounted on a 0.04 in² pad of 2 oz. copper.

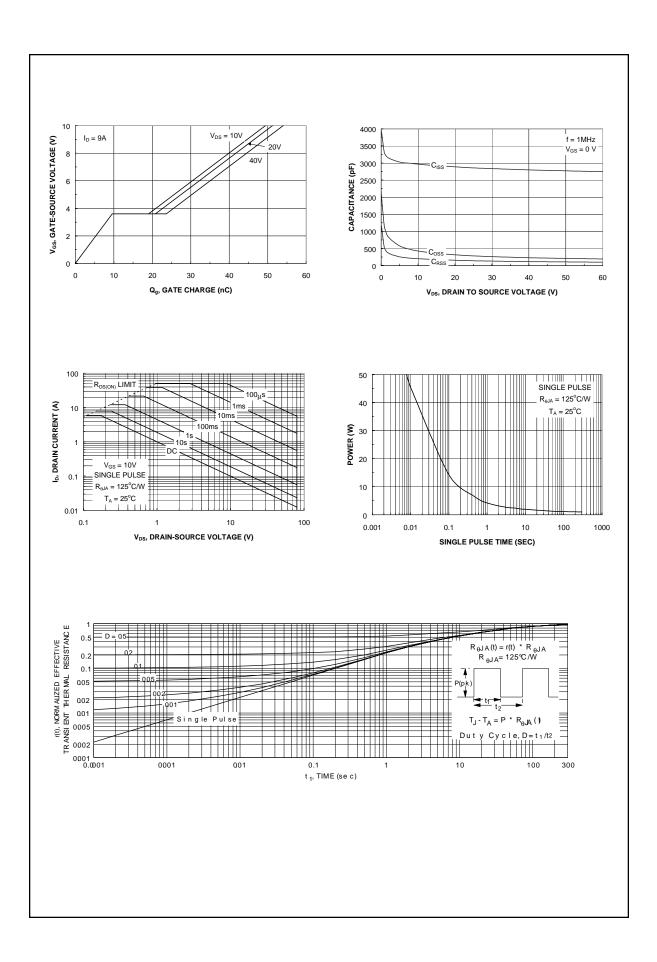


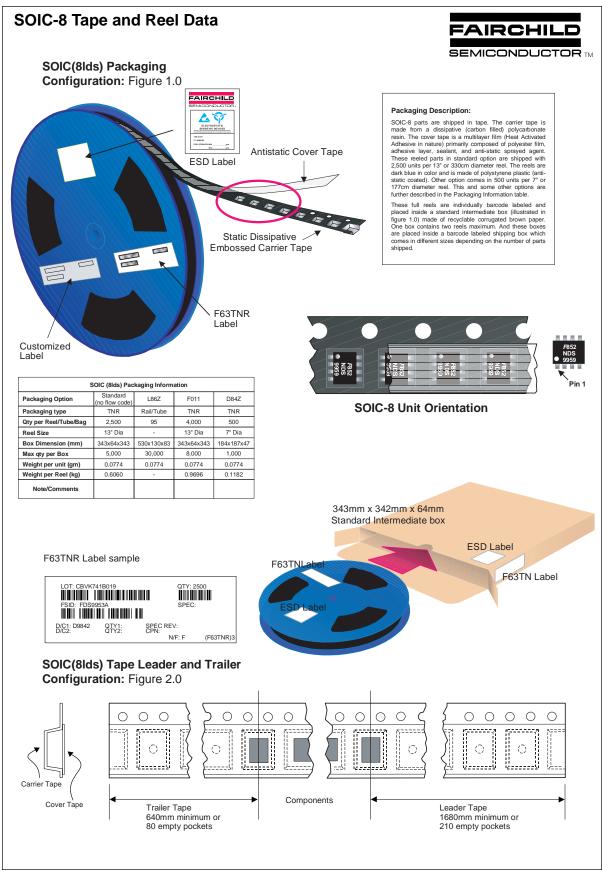
c) 125° C/W when mounted on a minimum pad.

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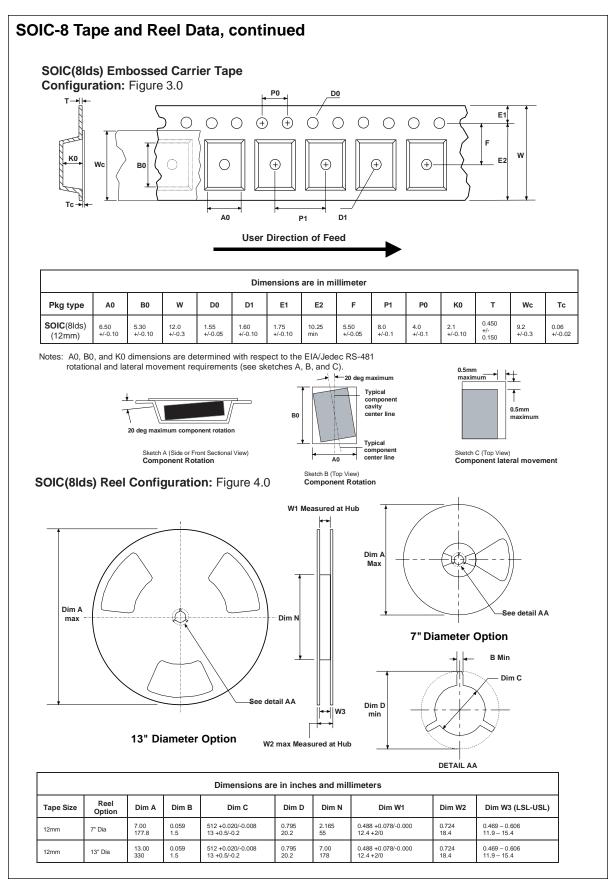
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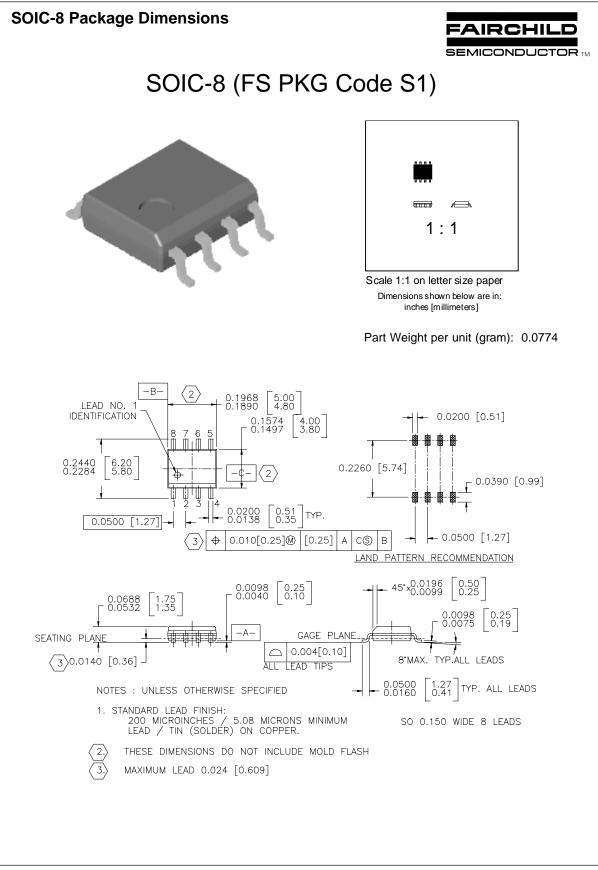




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